



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Ting Kuo Chen : Group

Serial No: 09/686,895 : Art Unit #2125

Filed: 12 October 2000 : Examiner:

Title: SMART AUTOMATIC RECORDING : M.N. Von

SYSTEM AND METHOD FOR

MONITORING WAFER FRAGMENTATION:

AMENDMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450 RECEIVED

JUL 1 6 2004

Technology Center 2100

Sir:

Buhr

This is responsive to the non-Final Office Action dated 16 March 2004.

A Request and fee for a one (1) month Extension of Time has been concurrently filed herewith.

Please amend the above-referenced Patent Application as follows:

Amendments in the Drawings begin on page 2 of this paper.

Amendments in the Specification begin on page 3 of this paper.

Amendments to the Claims are reflected in the Listing of Claims which begins on page 7 of this paper.

Remarks begin on page 12 of this paper.

An Appendix including two replacement drawing sheets of FIGS 3 and 4, respectively, are attached following page 17 of this paper.

